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LH0070 Series Precision BCD Buffered Reference LH0071 Series Precision Binary Buffered Reference

General Description

The LH0070 and LH0071 are precision, three terminal, voltage references consisting of a temperature compensated zener diode driven by a current regulator and a buffer amplifier. The devices provide an accurate reference that is virtually independent of input voltage, load current, temperature and time. The LH0070 has a 10.000V nominal output to provide equal step sizes in BCD applications. The LH0071 has a 10.240V nominal output to provide equal step sizes in binary applications.

The output voltage is established by trimming ultra-stable, low temperature drift, thin film resistors under actual operating circuit conditions. The devices are shortcircuit proof in both the current sourcing and sinking directions.

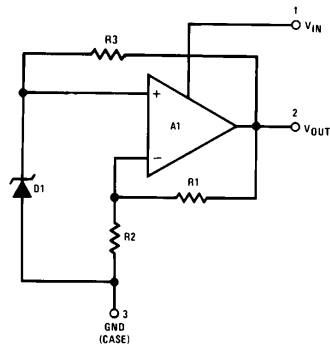
The LH0070 and LH0071 series combine excellent long term stability, ease of application, and low cost, making

them ideal choices as reference voltages in precision D to A and A to D systems.

Features

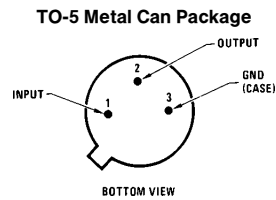
- Accuracy output voltage
 - LH0070 $10V \pm 0.02\%$
 - LH0071 $10.24V \pm 0.02\%$
- Single supply operation $11.4V$ to $40V$
- Low output impedance 0.2Ω
- Excellent line regulation 0.1 mV/V
- Low zener noise $20\text{ }\mu\text{Vp-p}$
- 3-lead TO-5 (pin compatible with the LM109)
- Short circuit proof
- Low standby current 3 mA

Equivalent Schematic



TL/H/5550-1

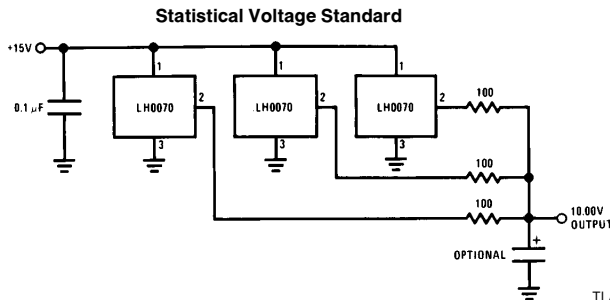
Connection Diagram



TL/H/5550-7

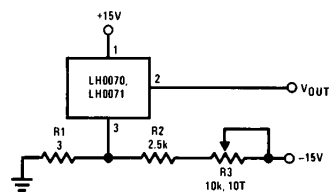
Order Number LH0070-0H, LH0071-0H, LH0070-1H,
 LH0071-1H, LH0070-2H or LH0071-2H
 See NS Package Number H03B

Typical Applications



TL/H/5550-8

*Output Voltage Fine Adjustment



TL/H/5550-9

***Note:** The output of the LH0070 and LH0071 may be adjusted to a precise voltage by using the above circuit since the supply current of the devices is relatively small and constant with temperature and input voltage. For the circuit shown, supply sensitivities are degraded slightly to 0.01%/V change in V_{OUT} for changes in V_{IN} and V^- .

An additional temperature drift of 0.0001%/°C is added due to the variation of supply current with temperature of the LH0070 and LH0071. Sensitivity to the value of R_1 , R_2 and R_3 is less than 0.001%/°C.

Absolute Maximum Ratings

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications. (Note 4)

Supply Voltage 40V
Power Dissipation (See Curve) 600 mW

Short Circuit Duration Continuous
Output Current ± 20 mA
Operating Temperature Range -55°C to $+125^{\circ}\text{C}$
Storage Temperature Range -65°C to $\pm 150^{\circ}\text{C}$
Lead Temp. (Soldering, 10 seconds) 300°C

Electrical Characteristics (Note 1)

Parameter	Conditions	Min	Typ	Max	Units
Output Voltage LH0070 LH0071	$T_A = 25^{\circ}\text{C}$		10.000 10.24		V V
Output Accuracy -0, -1 -2	$T_A = 25^{\circ}\text{C}$		± 0.03 ± 0.02	± 0.1 ± 0.05	% %
Output Accuracy -0, -1 -2	$T_A = -55^{\circ}\text{C}, 125^{\circ}\text{C}$			± 0.3 ± 0.2	% %
Output Voltage Change With Temperature -0 -1 -2	(Note 2)		± 0.02 ± 0.01	± 0.2 ± 0.1 ± 0.04	% % %
Line Regulation -0, -1 -2	$13\text{V} \leq V_{IN} \leq 33\text{V}, T_C = 25^{\circ}\text{C}$		0.02 0.01	0.1 0.03	% %
Input Voltage Range	$R_L = 50\text{ k}\Omega$	11.4		40	V
Load Regulation	$0\text{ mA} \leq I_{OUT} \leq 5\text{ mA}$		0.01	0.03	%
Quiescent Current	$13\text{V} \leq V_{IN} \leq 33\text{V}, I_{OUT} = 0\text{ mA}$	1	3	5	mA
Change In Quiescent Current	$\Delta V_{IN} = 20\text{V}$ From 23V To 33V		0.75	1.5	mA
Output Noise Voltage	$BW = 0.1\text{ Hz To } 10\text{ Hz}, T_A = 25^{\circ}\text{C}$		20		$\mu\text{Vp-p}$
Ripple Rejection	$f = 120\text{ Hz}$		0.01		%/Vp-p
Output Resistance			0.2	0.6	Ω
Long Term Stability -0, -1 -2	$T_A = 25^{\circ}\text{C}$ (Note 3)			± 0.2 ± 0.05	%/yr. %/yr.
Thermal Resistance θ_{ja} (Junction to Ambient) θ_{jc} (Junction to Case)	$T_j = 150^{\circ}\text{C}$		200 100		$^{\circ}\text{C/W}$ $^{\circ}\text{C/W}$

Note 1: Unless otherwise specified, these specifications apply for $V_{IN} = 15.0\text{V}$, $R_L = 10\text{ k}\Omega$, and over the temperature range of $-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$.

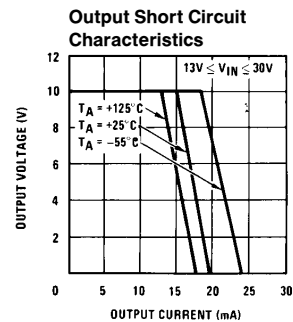
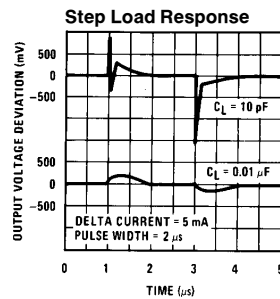
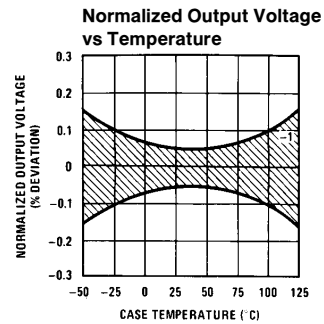
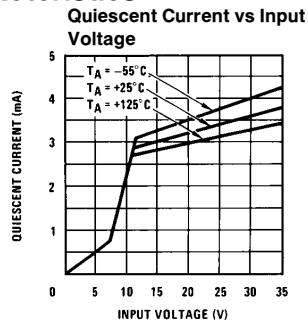
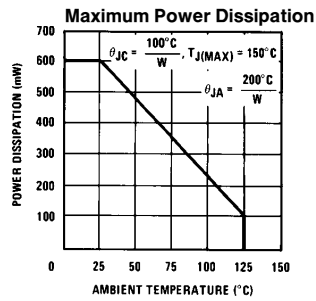
Note 2: This specification is the difference in output voltage measured at $T_A = 85^{\circ}\text{C}$ and $T_A = 25^{\circ}\text{C}$ or $T_A = 25^{\circ}\text{C}$ and $T_A = -25^{\circ}\text{C}$ with readings taken after test chamber and device-under-test stabilization at temperature using a suitable precision voltmeter.

Note 3: This parameter is guaranteed by design and not tested.

Note 4: Refer to the following RETS drawings for military specifications:

RETS0070-0H for LH0070-0H	RETS0071-0H for LH0071-0H
RETS0070-1H for LH0070-1H	RETS0071-1H for LH0071-1H
RETS0070-2H for LH0070-2H	RETS0071-2H for LH0071-2H

Typical Performance Characteristics

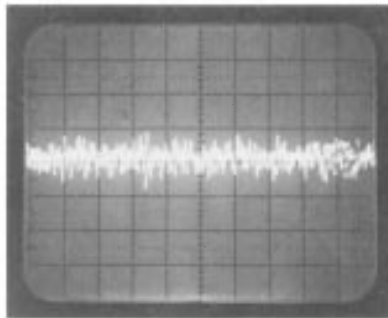


TL/H/5550-2

Noise Voltage

VERT: 10 μV
DIV.

HORIZ: 5 SEC
DIV.

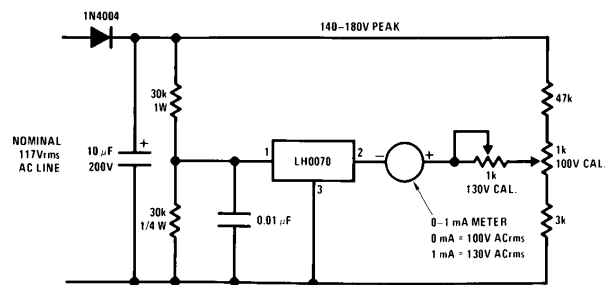


BW = 0.1 Hz TO 10 Hz

TL/H/5550-6

Typical Applications (Continued)

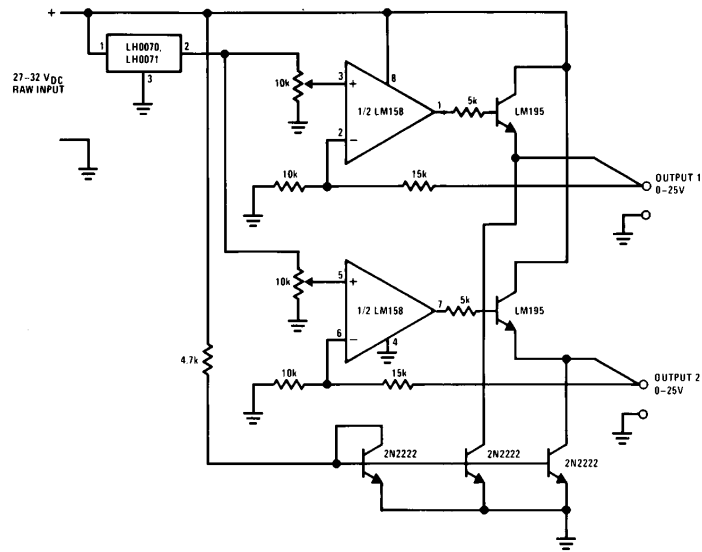
Expanded Scale AC Voltmeter



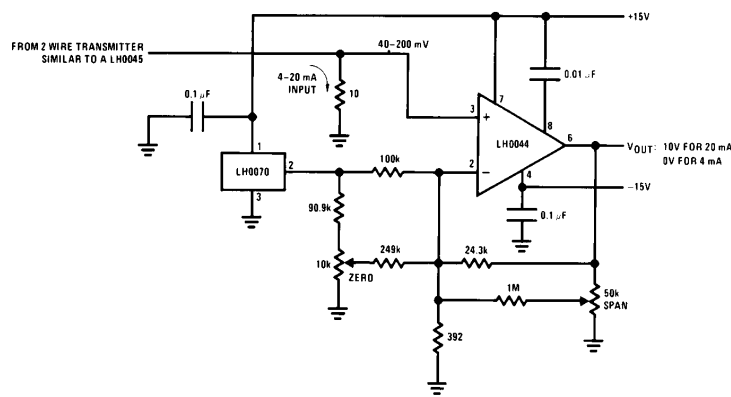
TL/H/5550-4

Typical Applications (Continued)

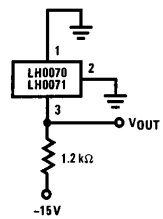
Dual Output Bench Power Supply



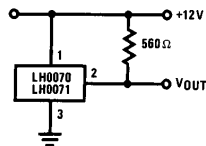
Precision Process Control Interface



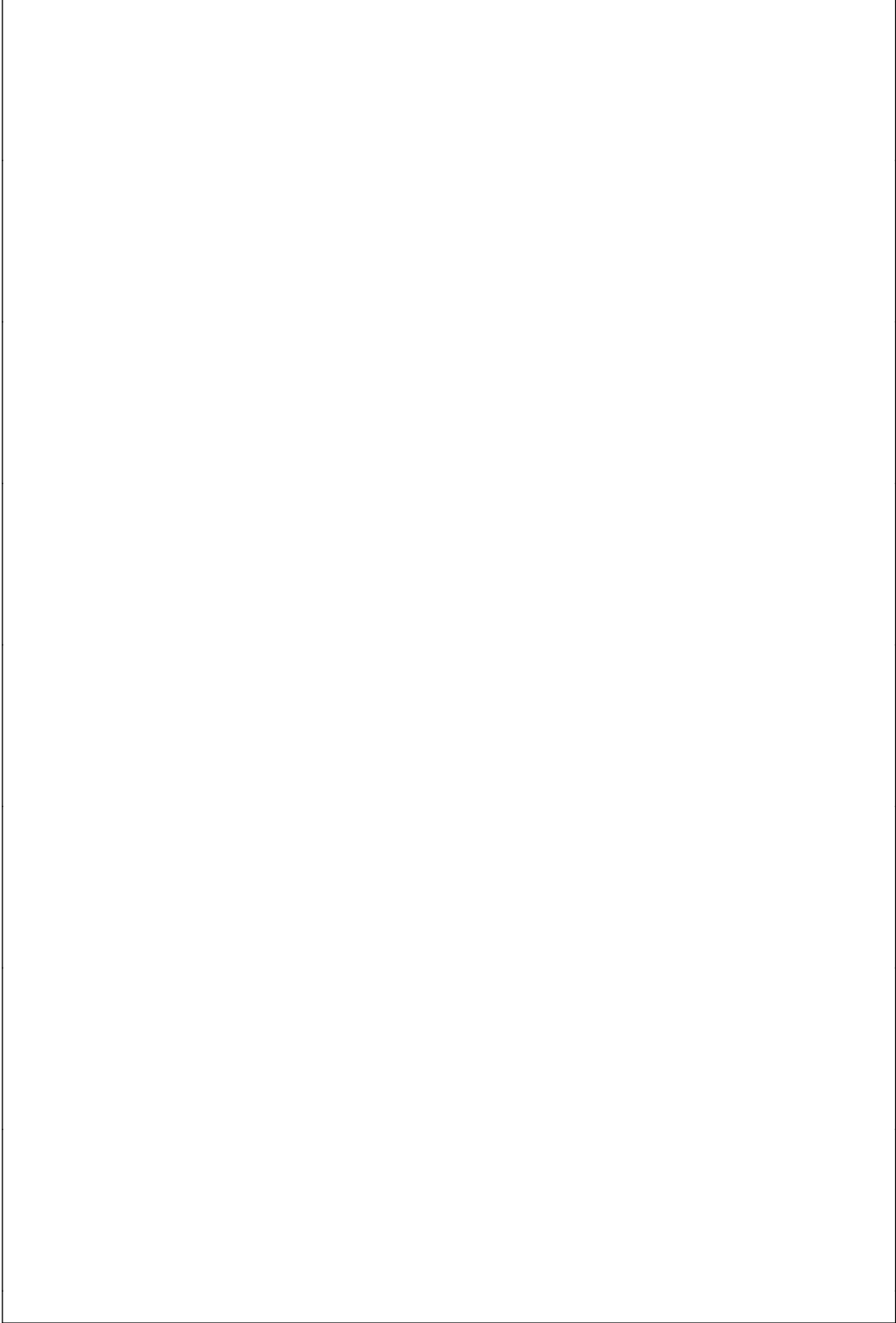
Negative 10V Reference



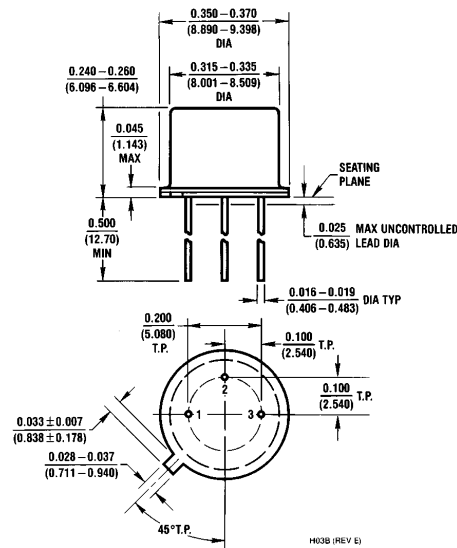
Boosted Reference For Low Input Voltages



TL/H/5550-5



Physical Dimensions inches (millimeters)



Metal Can Package (H)
Order Number LH0070-0H, LH0071-0H, LH0070-1H,
LH0071-1H, LH0070-2H or LH0071-2H
NS Package Number H03B

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